



FOR IMMEDIATE RELEASE

## **JGR Optics Introduces New TLS5 Tunable Laser Source**

Ottawa, Ontario, April 16, 2014 – JGR Optics Inc. announced today the availability of the new TLS5 Tunable Laser Source. The TLS5 delivers ultra-wide continuous wavelength tuning range of 1260nm to 1630nm at 0.1nm resolution, covering complete CWDM spectral range.

With a tuning speed of up to 100 nm per second and very good repeatability, the TLS5 is the perfect tunable laser source for characterization of CWDM and PON passive components.

In addition to front panel control, RS-232 and GPIB interfaces allow easy integration of the TLS5 in automated test systems for manufacturing applications.

The TLS5 will be demonstrated at FOE 2014 in Tokyo, Japan from April 16 to 19, 2014 (High Tech booth # 21-37).

### **About JGR Optics inc.**

Since the introduction of the innovative, industry-leading, Backreflection Meter (BR5) and Multi-Output Backreflection Meter (MBR5), JGR has expanded their portfolio to include the widely used MS12001 Cable Assembly Test System, industry leading Benchtop (SX4) and Rackmount (SX8) Optical Switches, Optical Attenuators (OA5) and the Polarization Dependant Loss Meter (PDL5). Through recent development JGR now also offers an ultra-wide wavelength range Tunable Laser Source (TLS5), a complete Environmental Optical Test System (EOTS) and the Wideband Component Test System (WCS).

In addition to research, development, and production within the JGR facility in Ottawa, Canada, they operate an ISO 17025:2005 Accredited Laboratory for repair and NIST-traceable calibration services.

For more information, please contact:

Mark Berezny  
613-599-1000  
[Mark.Berezny@jgroptics.com](mailto:Mark.Berezny@jgroptics.com)

